

UNIVERSITY OF DELHI SOUTH CAMPUS

MASTER OF TECHNOLOGY (M.Tech.) MICROWAVE ELECTRONICS

(IIIrd SEMESTER) EXAMINATION, 2011

The following candidates who appeared at the Master of Technology (M.Tech.) in Microwave Electronics IIIrd Semester Examination held in November/December, 2011, have secured the marks as shown against each. These candidates are eligible to promotion to the IVth semester class :

Roll No.	Enrol.No.	Name of Candidate	III Semester Marks Obtained (Out of 400)	I Semester Marks Obtained (Out of 500)
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DEPARTMENT OF ELECTRONIC SCIENCE, UDSC

1052	SDC-46/10	AJAY KUMAR TIWARI S/O PARAS NATH TIWARI	315	
1054	SDC-47/10	ARCHANA RAJPUT (W) D/O R.S. RAJPUT	329	
1058	SDC-41/10	GAURAV SAXENA S/O RAM KRISHNA SAHAYA	304	
1060	SDC-44/10	JEETENDRA SINGH S/O GYAN SINGH	288	
1062	SDC-63/10	LALIT KUMAR S/O MANTU RAM	330	
1064	SDC-50/10	MUKUL KUMAR YADAV S/O SHYAM KISHOR PRASAD	297	
1065	SDC-57/10	NAGENDRA KUSHWAHA S/O RAM REKHA KUSHWAHA	275	
1067	SDC-40/10	PANKAJ KUMAR PRASAD S/O JAY PRAKASH GUPTA	327	
1070	SDC-61/10	ROHIT KUMAR SAINI S/O RAJENDRA KR. SAINI	264	
1072	SDC-55/10	SANJEEV KUMAR S/O SITARAM YADAV	279	
1075	SDC-48/10	SAURABH VERMA S/O SURESH NATH VERMA	263	
9056	SDC-107/09	ASHOK KUMAR TIWARI S/O N.D. TIWARI	263	

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The following candidates is eligible for promotion to the IVth semester class but required to reappear in the paper/s noted against the name.

ROLL NO.	ENROL.NO.	NAME OF CANDIDATE	III Semester	I Semester
<u>DEPARTMENT OF ELECTRONIC SCIENCE, UDSC</u>				
1061	SDC-52/10	KUNAL SRIVASTAVA S/O ANIL KUMAR	271	ER-1.2
1068	SDC-56/10	PRAMOD KUMAR GUPTA S/O NANDLAL PRASAD GUPTA	290	ER-1.2
8055	SDC-81/08	GAURAV S/O R.M. DUBEY	276	ER-1.1

New Delhi, 28th December, 2011

(B.RAJA RAJAN)
Deputy Controller of Examinations.

: DISCLAIMER :
The Result displayed on University Website is subject to correction, if any discrepancy is noticed.